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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: James W. Adkisson, et al Examiner:

Serial No.: 10/7/0642

Group Art Unit:

Filed:

Docket: BUR920030194US1 (17344)

Unassigned

For: DESIGNING SCAN CHAINS WITH SPECIFIC

Dated: Ma

May 10, 2004

PARAMETER SENSITIVITIES TO IDENTIFY

PROCESS DEFECTS

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Sir:

In accordance with 37 C.F.R. §§ 1.97 and 1.98, it is requested that the following references, which are also listed on the attached Form PTO-1449, be made of record in the above-identified case.

Applicants are submitting copies of the cited references, along with an English Abstract which explains the pertinence of the reference.

CERTIFICATE OF MAILING UNDER 37 C.F.R. §1.8(a)

| I hereby certify that this correspondence is being deposited with the United |
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| States Postal Service as first class mail in an envelope addressed to: Commissioner for |
| Patents, Box 1450, Alexandria, VA 22313-1450 on 7-30-04. |

Dated: 7-30-04

P. L. de LANgis

Inasmuch as this Information Disclosure Statement is being submitted in accordance with the schedule set out in 37 C.F.R. § 1.97(b), no statement or fee is required.

Respectfully submitted,

William C. Roch

Registration No.: 24,972

Scully, Scott, Murphy & Presser 400 Garden City Plaza Garden City, New York 11530 (516) 742-4343

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| INFORMATION DISCLOSURE EITATION (Use several sheets if necessary) AUG 0 3 2004 | | | | Docket Number (Optional) BUR920030194US1 (17344) | | Application Number | | | | |
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| | | | | 7-27-04 Unassigned | | | | | | |
| U.S. PATENT DOCUMENTS | | | | | | | | | | |
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| | | EP146661A1 | 12/16/86 | EPO | | | | | | |
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| OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.) | | | | | | | | | | |
| | At-Speed Test Is Not Necessarlily An AC Test, by Jacob Savir and Robert Berry, Int'l Test Conf. 1991. | | | | | | | | | |
| | | IBM Technical Disclosure Bulletin 8-86 P. 1234-1236, Measuring Process-Induced AC Chip Performance Variations Using SRLs. | | | | | | | | |
| | | IBM Technical Disclosure Bulletin 3-88 P. 288, Process Monitoring For LSSD Designs. | | | | | | | | |
| EXAMINER | | | | | DATE CONSIDER | ED | | | | |
| EXAMINER: In considered. Inc | EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. | | | | | | | | | |